

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination HEENAN ET AL.
	Examiner James Phan	Art Unit 2872

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	K	US-			
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FOREIGN PATENT DOCUMENTS

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	N	DE 4236799	05-1994	Deutsches		
	O					
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NON-PATENT DOCUMENTS

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